Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/736,269	HAYWARD ET AL.	
Examiner	Art Unit	
Sophia S. Chen	2852	

SEARCHED					
Class	Subclass	Date	Examiner		
399	24, 25, 26, 28, 29, 30	7/20/2005	sc		
above	updated	11/29/2005	sc		
		<u> </u>			
		,			
			4.		

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
Interfer	ence Sear Printout	ch 11/29/2005	sc			
0		·				
<u>:</u>						

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
S.N. 09/397126, 09/662198, 09/662284 references checked 399/27 (USPAT and US-PGPUB only)	7/20/2005 Uplated	sc (SC)		
399/8 (text search only) - see search history printout 347/19,50,86 (text search only) - see search history printout	7/20/2005 /uplated on ///29/05/	sc (SC)		
705/27,26 (text search only) - see search history printout 709/224 (text search only) - see search history printout	7/20/2005 Updated	sc (SC)		
EAST (USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB) - see search history printout EAST (EPO, JPO) - see search history Printout	7/20/2005 Supdated	sc (SC)		
	Cijayiray			